August 2001

FAIRCHILD SEMICONDUCTOR TM

FDS3601 100V Dual N-Channel PowerTrench[®] MOSFET

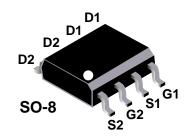
General Description

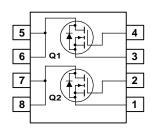
These N-Channel MOSFETs have been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{_{\text{DS}(\text{ON})}}$ specifications. The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- 1.3 A, 100 V. $R_{DS(ON)} = 480 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 530 \text{ m}\Omega @ V_{GS} = 6 \text{ V}$
- Fast switching speed
- Low gate charge (3.7nC typical)
- + High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		100	V
V _{GSS}	Gate-Source Voltage		±20	V
I _D	Drain Current – Continuous	(Note 1a)	1.3	А
	– Pulsed		6	
P _D	Power Dissipation for Dual Operation		2	W
	Power Dissipation for Single Oper	ration (Note 1a)	1.6	
		(Note 1b)	1.0	
		(Note 1c)	0.9	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +175	°C
Therma	I Characteristics			
R _{θJA}	Thermal Resistance, Junction-to-Ambient (Note 1a)		78	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case (Note 1)		40	°C/W
Packag	e Marking and Orderin	g Information		
Device I	Marking Device	Reel Size	Tape width	Quantity
FDS	3601 FDS3601	13"	12mm	2500 units

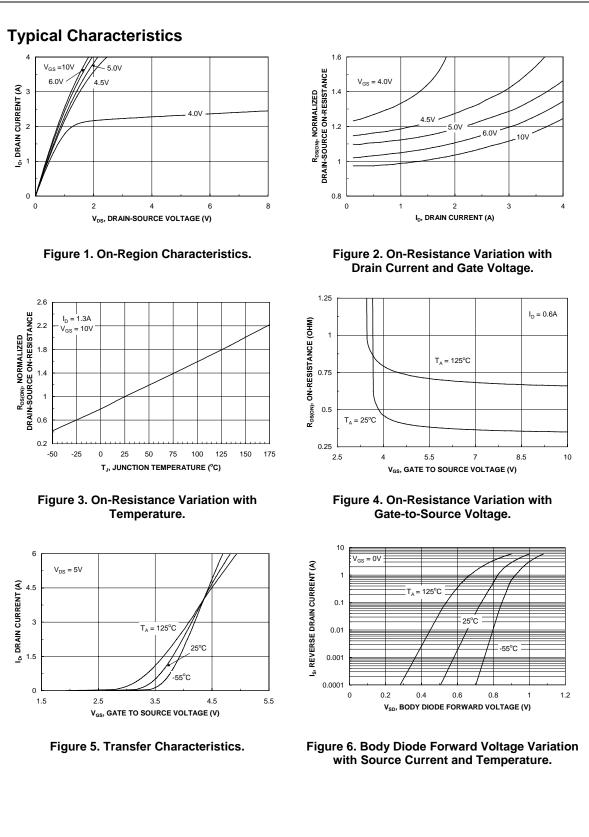
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FDS3601

1.3 A	single Pulse, V _{DD} = 50 V, I _D = 1.3 A	in-Source Avalanche Ratings (Note
100 V °C 105 mV/°C 100 μA		
100 V °C 105 mV/°C 10 μΑ	J	Drain-Source Avalanche Energy
°C 105 mV/°C 10 μΑ		Drain-Source Avalanche Current
°C 105 mV/°C 10 μΑ		Characteristics
10 μA	$V_{GS} = 0 V, I_D = 250 \mu A$	s Drain–Source Breakdown Voltage
- P# 1	$I_D = 250 \ \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$	Breakdown Voltage Temperature Coefficient
100 nA	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$	Zero Gate Voltage Drain Current
	$V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$	Gate-Body Leakage, Forward
–100 nA	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$	Gate-Body Leakage, Reverse
<u> </u>	· · ·	Characteristics (Note 2)
2 2.6 4 V	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	Gate Threshold Voltage
°C _5 mV/°C	$I_D = 250 \ \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$	(th) Gate Threshold Voltage Temperature Coefficient
350 480 mΩ 376 530 530 5°C 664 955		n) Static Drain–Source On–Resistance
3 A	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$	On–State Drain Current
3.6 S	$V_{DS} = 5V$, $I_D = 1.3 A$	Forward Transconductance
	· · · · · ·	amic Characteristics
153 pF	$V_{DS} = 50 V$, $V_{GS} = 0 V$,	Input Capacitance
5 pF	f = 1.0 MHz	Output Capacitance
1 pF		Reverse Transfer Capacitance
	· · · · · ·	tching Characteristics (Note 2)
8 16 ns	$V_{DD} = 50 V$, $I_D = 1 A$,	Turn–On Delay Time
4 8 ns	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	Turn–On Rise Time
11 20 ns	1	Turn–Off Delay Time
6 12 ns	1 1	Turn–Off Fall Time
3.7 5 nC	$V_{DS} = 50 V$, $I_D = 1.3 A$.	Total Gate Charge
0.8 nC	V _{GS} = 10 V	
1 nC	1 1	Gate–Drain Charge
	and Maximum Ratings	in-Source Diode Characteristics
1.3 A		
	$V_{GS} = 0 \text{ V}, I_S = 1.3 \text{ A} (\text{Note 2})$	Drain–Source Diode Forward
11 20 6 12 3.7 5 0.8 1 1 1.3	$V_{DS} = 50 \text{ V}, I_D = 1.3 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Ratings Diode Forward Current $V_{GS} = 0 \text{ V}, I_S = 1.3 \text{ A} (\text{Note 2})$ al resistance where the case thermal reference is	Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge in-Source Diode Characteristics Maximum Continuous Drain-Source

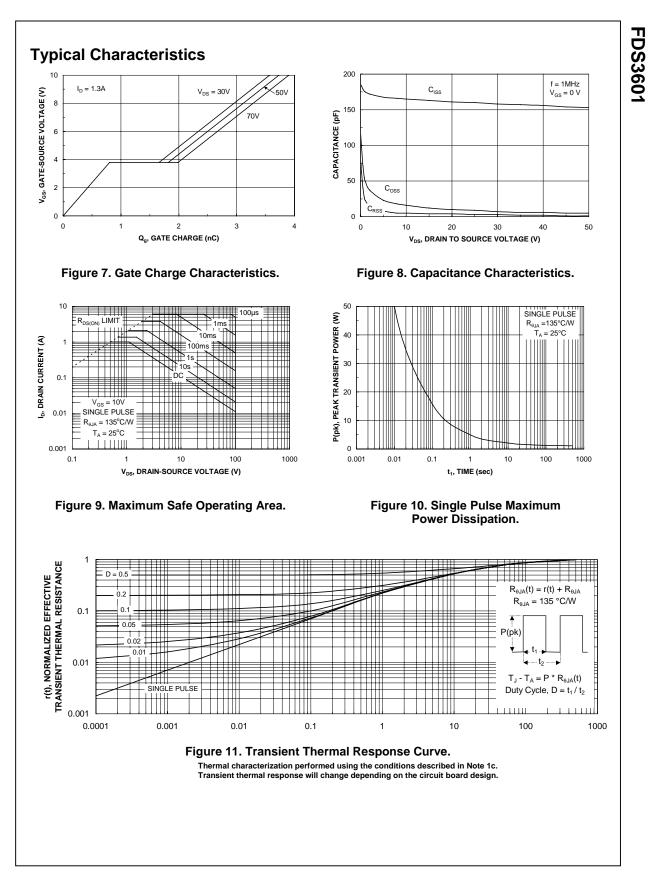
2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

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FDS3601

FDS3601 Rev C(W)



FDS3601 Rev C(W)

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Rev. H				